Hearing Aid Compatibility (HAC) TEST REPORT

<For RF-Emission Measurement>

Applicant Name	HP Inc
Address of Applicant	3390 East Harmony Road Fort Collins, Colorado 80528 United States
EUT Name	Phablet
Brand Name	HP
Model No.	HSTNH-F606V
FCC ID	B94HHF606V
Date of receive	May. 06, 2016
Date of Test(s)	May. 13, 2016 , Mar. 03, 2017
Date of Issue	Mar. 16, 2017

Standards:

ANSI C63.19-2011

FCC RULE PART(S): 47 CFR PART 20.19(B)
HAC CATEGORY: M4 (M Category)

In the configuration tested, the EUT complied with the standards specified above.

Remarks:

This report details the results of the testing carried out on one sample, the results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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Signed on behalf of SGS

Engineer	**Supervisor**
Matt Kuo	John Yeh
Matt Kuo	**John Yeh**
Date: Mar. 16, 2017	**Date: Mar. 16, 2017**

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Revision History

Report Number	Revision	Description	Issue Date
E5/2017/10013	Rev.00	Initial creation of document	Mar. 16, 2017

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1. Introduction

The purpose of the Hearing Aid Compatibility is to enable measurements of the near electric fields generated by wireless communication devices in the region controlled for use by a hearing aid in accordance with ANSI-C63.19-2011

The purpose of this standard is to establish categories for hearing aids and for WD (wireless communications devices) that can indicate to health care practitioners and hearing aid users which hearing aids are compatible with which WD, and to provide tests that can be used to assess the electromagnetic characteristics of hearing aids and WD and assign them to these categories. The various parameters required, in order to demonstrate compatibility and accessibility are measured. The design of the standard is such that when a hearing aid and WD achieve one of the categories specified, as measured by the methodology of this standard, the indicated performance is realized.

In order to provide for the usability of a hearing aid with a WD, several factors must be coordinated:
a) Radio frequency (RF) measurements of the near-field electric fields emitted by a WD to categorize these emissions for correlation with the RF immunity of a hearing aid.

Hence, the following are measurements made for the WD:
RF E-Field emissions

The measurement plane is parallel to, and 1.5cm in front of, the reference plane.

Applications for certification of equipment operation under part 20, that a manufacturer is seeking to certify as hearing aid compatible, as set forth in §20.19 of that part, shall include a statement indication compliance with the test requirements of §20.19 and indicating the appropriate U-rating for the equipment. The manufacturer of the equipment shall be responsible for maintaining the test results.

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2. Testing Laboratory

Company Name	SGS Taiwan Ltd. Electronics & Communication Laboratory
Company address	No.2, Keji 1st Rd., Guishan Township, Taoyuan County 333, Taiwan (R.O.C.)
Telephone	+886-2-2299-3279
Fax	+886-2-2298-0488
Website	http://www.tw.sgs.com/

3. Details of Applicant

Applicant Name	HP Inc.
Applicant Address	3390 East Harmony Road Fort Collins, Colorado 80528 United States

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4. Description of EUT

EUT Name	Phablet	
Brand Name	HP	
Model No.	HSTNH-F606V	
FCC ID	B94HHF606V	
Mode of Operation	☒GSM ☒GPRS ☒EDGE ☒WCDMA ☒HSDPA ☒HSUPA ☒HSPA+ ☒LTE FDD ☒CDMA 1xRTT ☒CDMA EVDO Rev.0/ Rev.A ☒WLAN802.11 a/b/g/n/ac (20M/40M/80M) ☒Bluetooth	
Duty Cycle	GSM	1/8.3
	GPRS (support multi class 12 max)	1/2 (1Dn4UP) 1/2.76 (1Dn3UP) 1/4.1 (1Dn2UP) 1/8.3 (1Dn1UP)
	EDGE (support multi class 12 max)	1/2 (1Dn4UP) 1/2.76 (1Dn3UP) 1/4.1 (1Dn2UP) 1/8.3 (1Dn1UP)
	WCDMA	1
	CDMA 1xRTT / EVDO Rev.0/ Rev. A	1
	LTE(data only, not support VoLTE)	1
	WLAN 802.11 a/b/g/n/ac(20M/40M/80M)	1
	Bluetooth	1

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TX Frequency Range (MHz)	GSM850	824	–	848
	GSM1900	1850	–	1910
	WCDMA Band II	1850	–	1910
	WCDMA Band IV	1710	–	1755
	WCDMA Band V	824	–	848
	CDMA Cellular (BC0)	824	–	848
	CDMA PCS (BC1)	1850	–	1910
	LTE FDD Band II	1850	–	1910
	LTE FDD Band IV	1710	–	1755
	LTE FDD Band V	824	–	849
	LTE FDD Band VII	2500	–	2570
	LTE FDD Band XII	699	–	716
	LTE FDD Band XIII	777	–	787
	LTE FDD Band XXX	2305	–	2315
	WLAN802.11 b/g/n(20M)	2412	–	2462
	WLAN802.11 n(40M)	2422	–	2452
	WLAN802.11 a/n(20M)/ac(20M) 5.2G	5180	–	5240
	WLAN802.11 n(40M)/ac(40M) 5.2G	5190	–	5230
	WLAN802.11 ac(80M) 5.2G	5210		
	WLAN802.11 a/n(20M)/ac(20M) 5.3G	5260	–	5320
	WLAN802.11 n(40M)/ac(40M) 5.3G	5270	–	5310
	WLAN802.11 ac(80M) 5.3G	5290		
	WLAN802.11 a/n/ac(20M) 5.6G	5500	–	5720
	WLAN802.11 n/ac(40M) 5.6G	5510	–	5710
	WLAN802.11 ac(80M) 5.6G	5530	–	5690

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TX Frequency Range (MHz)	WLAN802.11 a/n(20M)/ac(20M) 5.8G	5745	–	5825
	WLAN802.11 n(40M)/ac(40M) 5.8G	5710	–	5795
	WLAN802.11 ac(80M) 5.8G	5775		
	Bluetooth	2402	–	2480
Channel Number (ARFCN)	GSM850	128	–	251
	GSM1900	512	–	810
	WCDMA Band II	9262	–	9538
	WCDMA Band IV	1312	–	1513
	WCDMA Band V	4132	–	4233
	CDMA Cellular (BC0)	1013	–	777
	CDMA PCS (BC1)	25	–	1175
	LTE FDD Band II	18607	–	19193
	LTE FDD Band IV	19957	–	20393
	LTE FDD Band V	20407	–	20643
	LTE FDD Band VII	20775	–	21425
	LTE FDD Band XII	23007	–	23173
	LTE FDD Band XIII	23205	–	23255
	LTE FDD Band XXX	27685	–	27735
	WLAN 802.11 b/g/n(20M)	1	–	11
	WLAN802.11 n (40M)	3	–	9
	WLAN802.11a/n(20M)/ac(20M) 5.2G	36	–	48
	WLAN802.11n(40M)/ac(40M) 5.2G	38	–	46
	WLAN802.11 ac(80M) 5.2G	42		
	WLAN802.11 a/n(20M)/ac(20M) 5.3G	52	–	64

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Channel Number (ARFCN)	WLAN802.11 n(40M)/ac(40M) 5.3G	54	–	62
	WLAN802.11 ac(80M) 5.3G	58		
	WLAN802.11 a/n/ac(20M) 5.6G	100	–	144
	WLAN802.11 ac(80M) 5.6G	106	–	138
	WLAN802.11 n/ac(40M) 5.6G	102	–	142
	WLAN802.11 a/n(20M)/ac(20M) 5.8G	149	–	165
	WLAN802.11 n(40M)/ac(40M) 5.8G	142	–	159
	WLAN802.11 ac(80M) 5.8G	155		
	Bluetooth	0	–	78

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5. Air Interfaces and Bands

Air- Interface	Band (MHZ)	Type Transport	C63.19 tested	Simultaneous Transmitter but not tested	Voice Over Digital Transport OTT capability	Power Reduction
GSM	850	VO	Yes	Yes, WiFi or Bluetooth	No	No
	1900				No	No
CDMA 1xRTT	BC0	VO	Yes	Yes, WiFi or Bluetooth	No	No
	BC1				No	No
CDMA EVDO Rev.0/ Rev. A	BC0	DT	NA	Yes, WiFi or Bluetooth	Yes	No
	BC1				Yes	No
WCDMA	II	VO	Yes (Note 1)	Yes, WiFi or Bluetooth	No	No
	IV				No	No
	V				No	No
LTE	II	DT	No	Yes, WiFi or Bluetooth	Yes	No
	IV				Yes	No
	V				Yes	No
	VII				Yes	No
	XII				Yes	No
	XIII				Yes	No
	XXX				Yes	No
WiFi	2450	DT	No	Yes, WWAN or BT	Yes	No
Bluetooth	2450	DT	No	Yes, WWAN or BT	No	No

VO= CMRS Voice Service DT= Digital Transport VD=CMRS IP Voice Service and Digital Transport	Note 1.It applies the low power exemption based on ANSI C63.19-2011

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6. Test Environment

Ambient Temperature	21.7° C
Relative Humidity	<80 %

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7. Description of test system

7.1 Measurement system Diagram for SPEAG Robotic

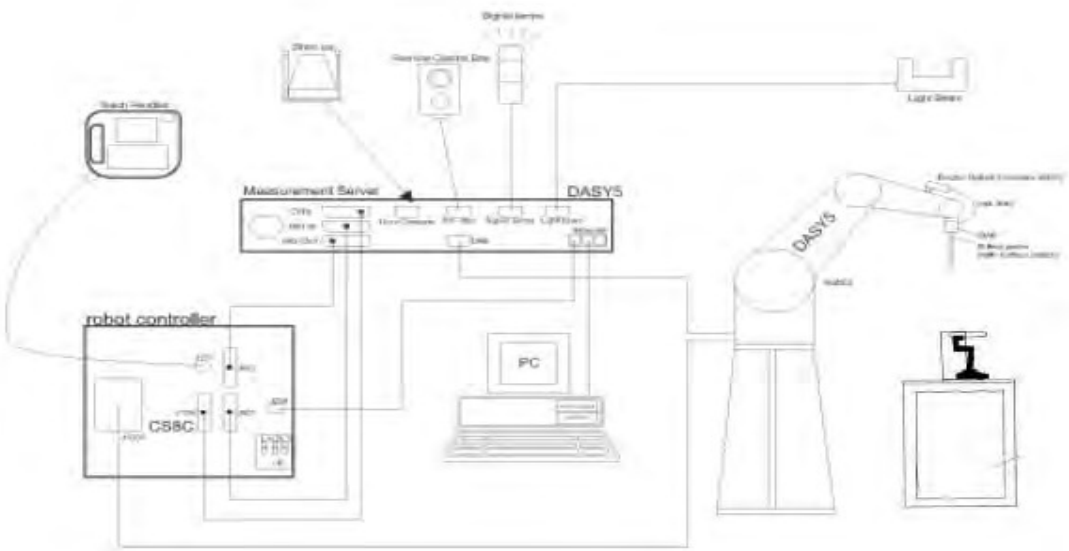

Fig.1 The SPEAG Robotic Diagram

The DASY5 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Staubli RX family) with controller, teach pendant and software. An arm extension is for accommodating the data acquisition electronics (DAE).
- E Field probe.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion between optical and electrical of the signals for the digital communication to the DAE and for the analog signal from the optical surface detection. The EOC is connected to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- A probe alignment unit which improves the (absolute) accuracy of the probe positioning.

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- A computer operating Windows 7.
- DASY5 software.
- Remote control with teach pendant and additional circuitry for robot safety such as warning lamps, etc.
- The Test Arch phantom.
- The device holder for handheld mobile phones.
- Validation dipole kits allowing to validate the proper functioning of the system.

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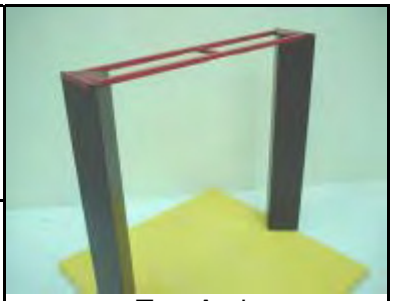
7.2 E Field Probe

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material	 ER3DV6 E-Field Probe
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)	
Frequency	(extended to 20 MHz for MRI), Linearity: ± 0.2 dB (100 MHz to 3 GHz)	
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)	
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB	
Dimensions	Tip diameter: 8 mm Distance from probe tip to dipole centers: 2.5 mm	

7.3 Test Arch

Description	Enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot.	 Test Arch
Dimensions	length: 370 mm width: 370 mm height: 370 mm	

7.4 Phone Holder

Description	Supports accurate and reliable positioning of any phone Effect on near field <+/- 0.5 dB	 Phone Holder

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8. Test Procedure

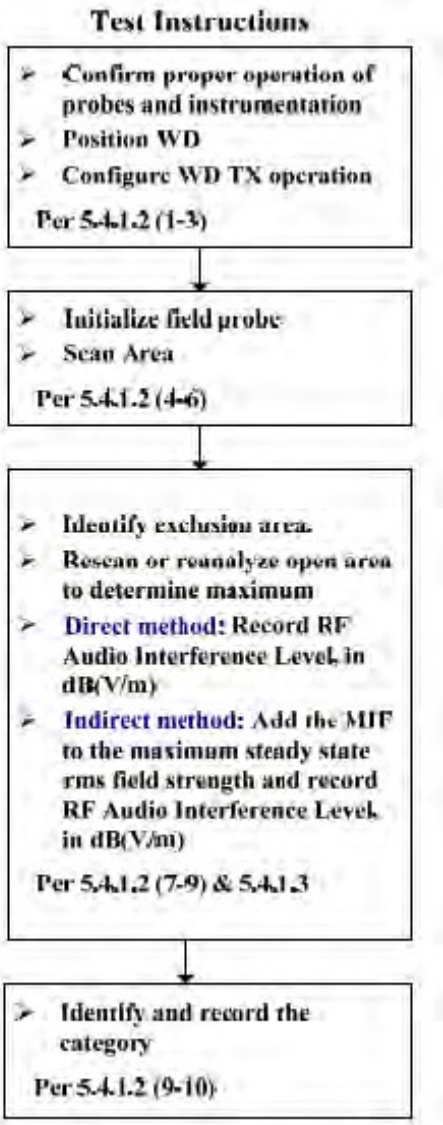

Fig.2 RF emission flow chart

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The following illustrate a typical RF emissions test scan over a wireless communications device (Indirect method):

1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
6. The measurement system measured the field strength at the reference location.
7. Measurements at 5mm increments in the 5 × 5 cm region were performed and recorded. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
8. The system performed a drift evaluation by measuring the field at the reference location.

Note.

Per KDB 285076 D01 v04r01 2.d) 1), handsets that that have the ability to support concurrent connections using simultaneous transmissions shall be independently tested for each air interface/band given in ANSI C63.19-2011. At the present time ANSI C63.19 does not provide simultaneous transmission test procedures.

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9. System Verification

A dipole antenna meeting the requirements given in ANSI C63.19-2011 was placed in the position normally occupied by the WD.

The length of the dipole was scanned by E-field probes and the maximum values for each were recorded.

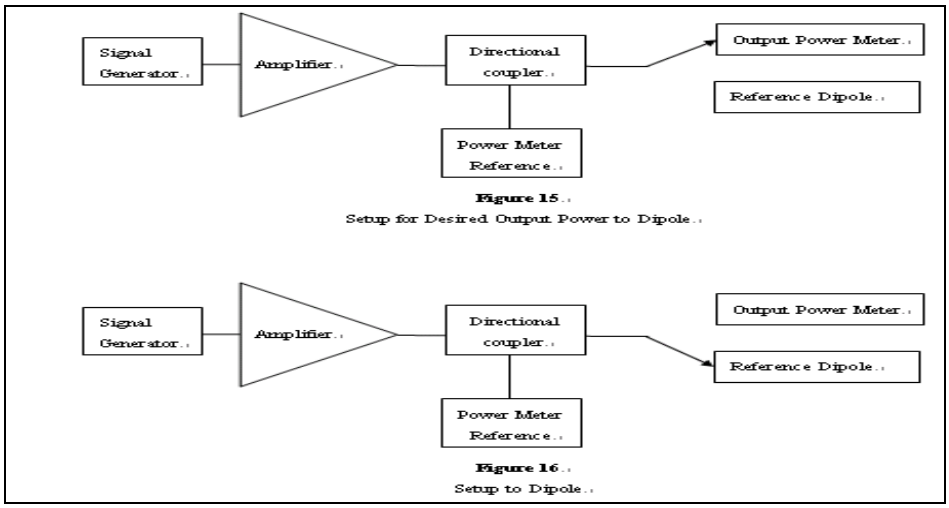

Fig.3 System verification

For E-Field Scan

Mode	Frequency (MHz)	Input Power(dBm)	E-Field 1 (V/m)	E-Field 2(V/m)	Target Value(V/m)	Deviation	Measured Date
CW	835	20	114.0	106.6	108.5	1.66%	May.13, 2016
CW	1880	20	101.4	90.46	87.8	9.25%	May.13, 2016
CW	835	20	114.0	106.5	108.5	1.61%	Mar.03, 2017
CW	1880	20	92.98	90.45	87.8	4.46%	Mar.03, 2017

Note:

For E-Field, the deviation is [(E-Field 1 + E-Field 2) / 2 – Target value] / Target value x 100%

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10. Modulation Interference Factor

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be developed that relates its interference potential to its steady-state rms signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF

The MIF may be determined using a radiated RF field or a conducted RF signal,

b) Using RF illumination or conducted coupling, apply the specific modulated signal in
question to the measurement system at a level within its confirmed operating dynamic range.

c) Measure the steady-state rms level at the output of the fast probe or sensor.

d) Measure the steady-state average level at the weighting output.

e) Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step d) measurement.

f) Without changing the carrier level from step e), remove the 1 kHz modulation and again
measure the steady-state rms level indicated at the output of the fast probe or sensor.

g) The MIF for the specific modulation characteristic is provided by the ratio of the step f)
measurement to the step c) measurement, expressed in dB (20 × log(step f))/step c)).

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Based on the KDB285076 D01, the handset can also use the MIF values predetermined by the test equipment manufacturer, and the following table lists the MIF values evaluated by DASY manufacturer (SPEAG), and the test result will be calculated with the MIF parameter automatically.

SPEAG UID	UID version	Communication system	MIF(dB)
10021	DAB (10.14.2015)	GSM-FDD (TDMA, GMSK)	3.63
10011	CAB (10.14.2015)	UMTS-FDD (WCDMA)	-27.23
10081	CAB (16.11.2016)	CDMA(SO3; RC3; full frame rate)	-19.71
10295	AAB (10.14.2015)	CDMA(SO3; RC1; 1/8 th frame rate)	3.26

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11. Measured conducted output power

Band	Channel	Average power(dBm)
GSM 850 (GMSK)	128	31.62
	190	31.69
	251	31.72
GSM 1900 (GMSK)	512	29.30
	661	29.53
	810	29.78
WCDMA Band II	9262	23.45
	9400	23.43
	9538	23.51
WCDMA Band IV	1312	23.49
	1412	23.24
	1513	23.28
WCDMA Band V	4132	24.05
	4183	23.87
	4133	24.11

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Band	Channel	Average power(dBm)
CDMA 1xRTT cellular(BC0) SO3;RC3	1013	23.33
	384	23.36
	777	23.19
CDMA 1xRTT cellular(BC0) SO3;RC1	1013	23.37
	384	23.46
	777	23.26
CDMA 1xRTT PCS(BC1) SO3;RC3	25	23.41
	600	23.58
	1175	23.43
CDMA 1xRTT PCS(BC1) SO3;RC1	25	23.41
	600	23.64
	1175	23.44

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12. Justification of held to ear modes tested

I. Analysis of RF air interface technologies

a. OTT data services are outside the current definition of a managed CMRS service and are currently not required to be evaluated.

b. Based on ANSI. C63.19-2011. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17 dBm for any of its operating modes. If a device supports multiple RF air interfaces, each RF air interface shall be evaluated individually.

The MIF plus the worst case average power for all modes are investigated below to determine the testing requirements for this device.

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II. Low power exemption

Air interference	Maximum power(dB)	MIF(dB)	Power + MIF (dB)	ANSI C63.19 2011 test required
GSM850	31.72	3.63	35.35	**Yes**
GSM1900	29.78	3.63	33.41	**Yes**
WCDMA B2	23.51	-27.23	-3.72	No
WCDMA B4	23.49	-27.23	-3.74	No
WCDMA B5	24.11	-27.23	-3.12	No
CDMA 1xRTT SO3;RC3	23.58	-19.71	3.87	No
CDMA 1xRTT SO3;RC1	23.64	3.26	26.90	**Yes**

We used the predetermined MIF to evaluate the low power exemption.

Based on ANSI. C63.19 2011, RF emission testing for WCDMA / CDMA 1xRTT SO3;RC3 is exempted.

Based on ANSI. C63.19 2011, WCDMA / CDMA 1xRTT SO3;RC3 that is exempted from testing shall be rated as M4.

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13. ANSI C63.19-2011 performance and categories

The measurements were performed to ensure compliance to the ANSI C63.19-2011 standard,

Category	E-Field Emissions dB(V/m) < 960MHz
M1	50-55
M2	45-50
M3	40-45
M4	<40

Category	E-Field Emissions dB(V/m) > 960MHz
M1	40-45
M2	35-40
M3	30-35
M4	<30

WD RF audio interference level categories in logarithmic units

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14. Instruments List

Manufacturer	Device	Type	Serial number	Date of last calibration	Date of next calibration
Schmid & Partner Engineering AG	E-Field Probe	ER3DV6	2306	Nov.20,2015	Nov.19,2016
				Nov.23,2016	Nov.22,2017
Schmid & Partner Engineering AG	835/1880 MHz System Validation Dipole	CD835V3	1052	Mar.17,2016	Mar.16,2017
		CD1880V3	1044	Mar.17,2016	Mar.16,2017
Schmid & Partner Engineering AG	Data acquisition Electronics	DAE4	1374	Oct.23,2015	Aug.22,2016
				Aug.23,2016	Aug.22,2017
Schmid & Partner Engineering AG	Software	DASY52 52.8.8	N/A	Calibration not required	Calibration not required
Agilent	Dielectric Probe Kit	85070D	US01440168	Calibration not required	Calibration not required
Agilent	Dual-directional coupler	778D	MY48220468	Jul.16,2015	Jul.15,2016
				Jul.06,2016	Jul.05,2017
Agilent	RF Signal Generator	N5181A	MY50141235	Dec.24,2015	Dec.23,2016
			MY50144143	Mar.01,2017	Feb.28,2018
R&S	Radio Communication Test	CMU200	122498	Aug.25,2015	Aug.24,2016
				Aug.19,2016	Aug.18,2017
Schmid & Partner Engineering AG	Test Arch SD HAC	P01	1047	Calibration not required	Calibration not required

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Manufacturer	Device	Type	Serial number	Date of last calibration	Date of next calibration
Agilent	Power Meter	E4417A	MY52240003	Jul.15,2015	Jul.14,2016
				Jan.20,2017	Jan.19,2018
Agilent	Power Sensor	E9301H	MY51470002	Jan.07,2016	Jan.06,2017
			MY52200004	Oct.17,2016	Oct.16,2017

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15. Summary of Results

E-Field

E-Field Emission	Channel	Modulation Interference Factor	Conducted Power (dBm)	Power Drift(dB)	Audio Interference Level dB(V/m)	RESULT	Excl Blocks per 4.3.1.2.2
GSM 850	128	3.63	31.62	-0.03	37.35	M4	236
	190	3.63	31.69	0.01	38.34	M4	236
	251	3.63	31.72	-0.02	38.52	M4	236
E-Field Emission	**Channel**	**Modulation Interference Factor**	**Conducted Power (dBm)**	**Power Drift(dB)**	**Audio Interference Level dB(V/m)**	**RESULT**	**Excl Blocks per 4.3.1.2.2**
GSM 1900	512	3.63	29.30	0.09	28.97	M4	789
	661	3.63	29.53	0.08	29.25	M4	789
	810	3.63	29.78	0.14	28.97	M4	689
E-Field Emission	**Channel**	**Modulation Interference Factor**	**Conducted Power (dBm)**	**Power Drift(dB)**	**Audio Interference Level dB(V/m)**	**RESULT**	**Excl Blocks per 4.3.1.2.2**
CDMA Cellular (BC0)	1013	3.26	23.37	-0.06	30.62	M4	236
	384	3.26	23.46	-0.00	31.05	M4	236
	777	3.26	23.26	0.04	31.02	M4	236
E-Field Emission	**Channel**	**Modulation Interference Factor**	**Conducted Power (dBm)**	**Power Drift(dB)**	**Audio Interference Level dB(V/m)**	**RESULT**	**Excl Blocks per 4.3.1.2.2**
CDMA PCS (BC1)	25	3.26	23.41	0.15	23.06	M4	789
	600	3.26	23.64	0.16	23.79	M4	689
	1175	3.26	23.44	-0.05	23.26	M4	689

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16. Measurement Data

Date: 2016/5/13

HAC-E_GSM 850_CH 128
Communication System: GSM; Frequency: 824.2 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section
DASY5 Configuration:

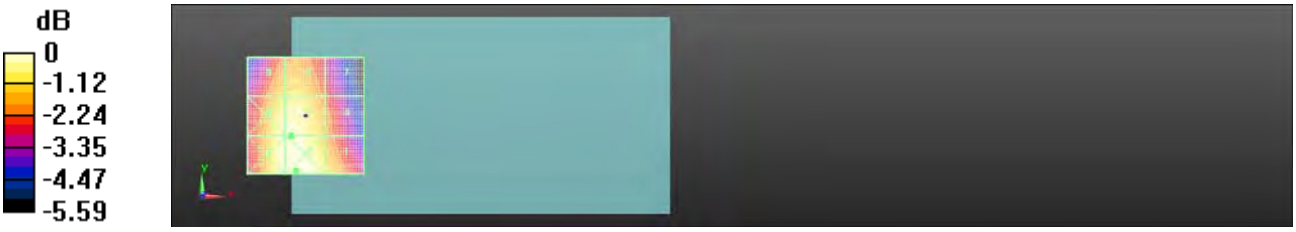
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 58.28 V/m; Power Drift = -0.03 dB
Applied MIF = 3.63 dB
RF audio interference level = 37.35 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **36.67 dBV/m**	Grid 2 **M4** **37.58 dBV/m**	Grid 3 **M4** **37.44 dBV/m**
Grid 4 **M4** **35.9 dBV/m**	Grid 5 **M4** **37.35 dBV/m**	Grid 6 **M4** **37.29 dBV/m**
Grid 7 **M4** **35.26 dBV/m**	Grid 8 **M4** **36.64 dBV/m**	Grid 9 **M4** **36.56 dBV/m**

Cursor:
Total = 37.58 dBV/m
E Category: M4
Location: -4, -23.5, 8.7 mm



0 dB = 75.68 V/m = 37.58 dBV/m

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Date: 2016/5/13

HAC-E_GSM 850_CH 190
Communication System: GSM; Frequency: 836.6 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

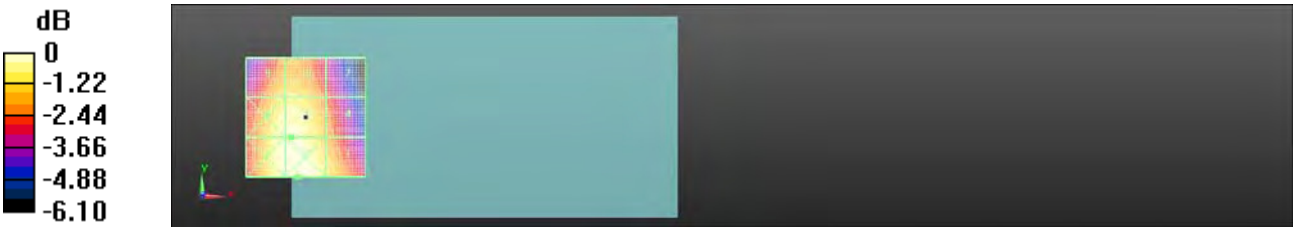
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 64.51 V/m; Power Drift = 0.01 dB
Applied MIF = 3.63 dB
RF audio interference level = 38.34 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **37.7 dBV/m**	Grid 2 **M4** **38.61 dBV/m**	Grid 3 **M4** **38.47 dBV/m**
Grid 4 **M4** **36.83 dBV/m**	Grid 5 **M4** **38.34 dBV/m**	Grid 6 **M4** **38.29 dBV/m**
Grid 7 **M4** **36.03 dBV/m**	Grid 8 **M4** **37.56 dBV/m**	Grid 9 **M4** **37.49 dBV/m**

Cursor:
Total = 38.61 dBV/m
E Category: M4
Location: -3.5, -25, 8.7 mm



0 dB = 85.24 V/m = 38.61 dBV/m

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Date: 2016/5/13

HAC-E_GSM 850_CH 251
Communication System: GSM; Frequency: 848.6 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

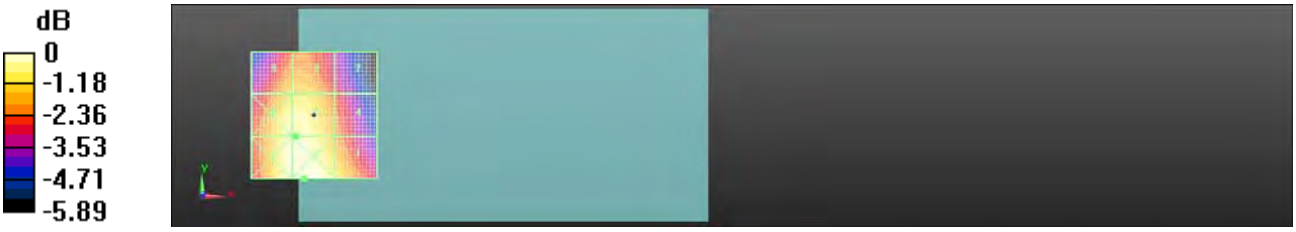
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 65.58 V/m; Power Drift = -0.02 dB
Applied MIF = 3.63 dB
RF audio interference level = 38.52 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **37.95 dBV/m**	Grid 2 **M4** **38.88 dBV/m**	Grid 3 **M4** **38.72 dBV/m**
Grid 4 **M4** **37 dBV/m**	Grid 5 **M4** **38.52 dBV/m**	Grid 6 **M4** **38.5 dBV/m**
Grid 7 **M4** **36.13 dBV/m**	Grid 8 **M4** **37.62 dBV/m**	Grid 9 **M4** **37.58 dBV/m**

Cursor:
Total = 38.88 dBV/m
E Category: M4
Location: -4, -25, 8.7 mm



0 dB = 87.87 V/m = 38.88 dBV/m

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Date: 2016/5/13

HAC-E_GSM 1900_CH 512
Communication System: GSM; Frequency: 1850.2 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 16.33 V/m; Power Drift = 0.09 dB
Applied MIF = 3.63 dB
RF audio interference level = 28.97 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **21.47 dBV/m**	Grid 2 **M4** **22.17 dBV/m**	Grid 3 **M4** **21.68 dBV/m**
Grid 4 **M4** **26.7 dBV/m**	Grid 5 **M4** **28.97 dBV/m**	Grid 6 **M4** **28.83 dBV/m**
Grid 7 **M4** **29.83 dBV/m**	Grid 8 **M3** **31.49 dBV/m**	Grid 9 **M3** **31.19 dBV/m**

Cursor:
Total = 31.49 dBV/m
E Category: M3
Location: -3, 25, 8.7 mm

0 dB = 37.53 V/m = 31.49 dBV/m

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Date: 2016/5/13

HAC-E_GSM 1900_CH 661
Communication System: GSM; Frequency: 1880 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

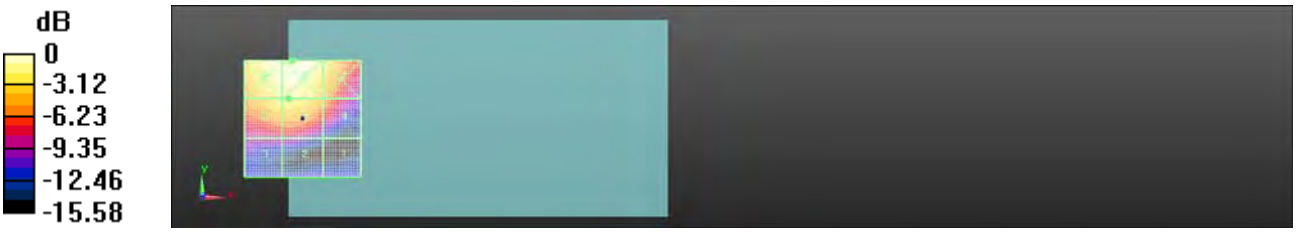
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 17.95 V/m; Power Drift = 0.08 dB
Applied MIF = 3.63 dB
RF audio interference level = 29.25 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **20.59 dBV/m**	Grid 2 **M4** **22.33 dBV/m**	Grid 3 **M4** **22.23 dBV/m**
Grid 4 **M4** **26.64 dBV/m**	Grid 5 **M4** **29.25 dBV/m**	Grid 6 **M4** **29.15 dBV/m**
Grid 7 **M4** **29.42 dBV/m**	Grid 8 **M3** **31.3 dBV/m**	Grid 9 **M3** **31.1 dBV/m**

Cursor:
Total = 31.30 dBV/m
E Category: M3
Location: -4.5, 25, 8.7 mm



0 dB = 36.71 V/m = 31.30 dBV/m

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Date: 2016/5/13

HAC-E_GSM 1900_CH 810
Communication System: GSM; Frequency: 1909.8 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

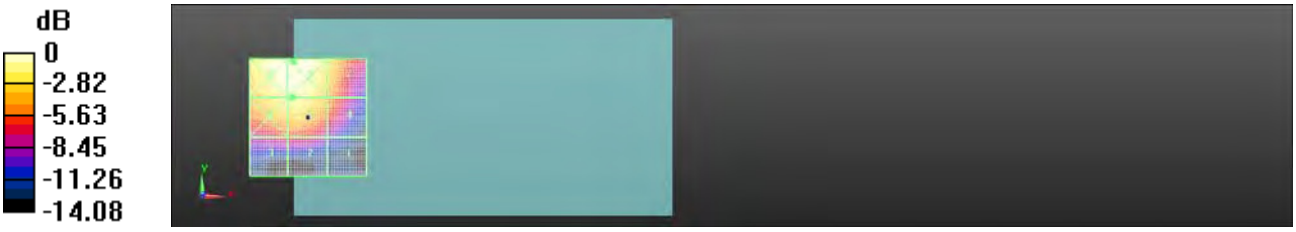
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 18.15 V/m; Power Drift = 0.14 dB
Applied MIF = 3.63 dB
RF audio interference level = 28.97 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **21.2 dBV/m**	Grid 2 **M4** **23.67 dBV/m**	Grid 3 **M4** **23.63 dBV/m**
Grid 4 **M4** **26.05 dBV/m**	Grid 5 **M4** **28.97 dBV/m**	Grid 6 **M4** **28.9 dBV/m**
Grid 7 **M4** **27.76 dBV/m**	Grid 8 **M3** **30.32 dBV/m**	Grid 9 **M3** **30.25 dBV/m**

Cursor:
Total = 30.32 dBV/m
E Category: M3
Location: -6, 24, 8.7 mm



0 dB = 32.80 V/m = 30.32 dBV/m

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Date: 2017/3/3

HAC-E_CDMA Cellular(BC0)_CH 1013
Communication System: CDMA; Frequency: 824.7 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

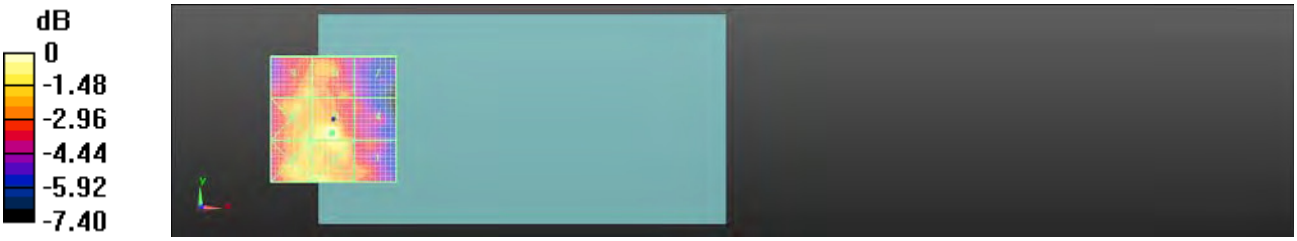
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch with AMCC
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 28.98 V/m; Power Drift = -0.06 dB
Applied MIF = 3.26 dB
RF audio interference level = 30.62 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **28.15 dBV/m**	Grid 2 **M4** **29.88 dBV/m**	Grid 3 **M4** **29.72 dBV/m**
Grid 4 **M4** **27.37 dBV/m**	Grid 5 **M4** **30.62 dBV/m**	Grid 6 **M4** **29.52 dBV/m**
Grid 7 **M4** **26.66 dBV/m**	Grid 8 **M4** **28.87 dBV/m**	Grid 9 **M4** **29.1 dBV/m**

Cursor:
Total = 30.62 dBV/m
E Category: M4
Location: -0.5, -5.5, 8.7 mm



0 dB = 33.95 V/m = 30.62 dBV/m

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Date: 2017/3/3

HAC-E_CDMA Cellular(BC0)_CH 384

Communication System: CDMA; Frequency: 836.52 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

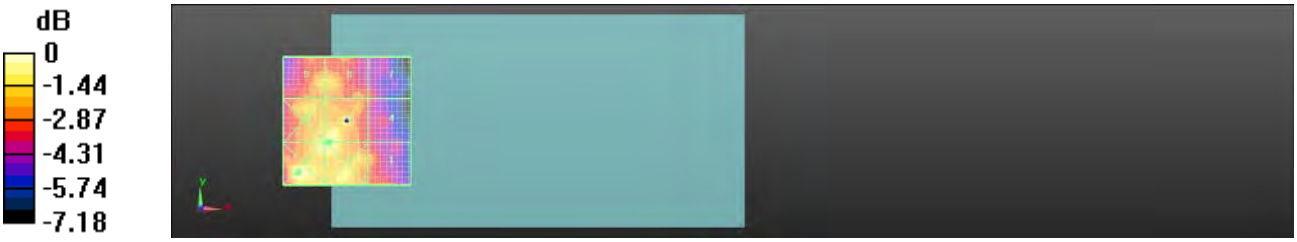
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch with AMCC
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 24.66 V/m; Power Drift = -0.00 dB
Applied MIF = 3.26 dB
RF audio interference level = 31.05 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **29.46 dBV/m**	Grid 2 **M4** **31.12 dBV/m**	Grid 3 **M4** **31.74 dBV/m**
Grid 4 **M4** **28.56 dBV/m**	Grid 5 **M4** **31.05 dBV/m**	Grid 6 **M4** **31.02 dBV/m**
Grid 7 **M4** **28.61 dBV/m**	Grid 8 **M4** **30.14 dBV/m**	Grid 9 **M4** **30.17 dBV/m**

Cursor:
Total = 31.74 dBV/m
E Category: M4
Location: -19, -20, 8.7 mm



0 dB = 38.62 V/m = 31.74 dBV/m

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Date: 2017/3/3

HAC-E_CDMA Cellular(BC0)_CH 777
Communication System: CDMA; Frequency: 848.31 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

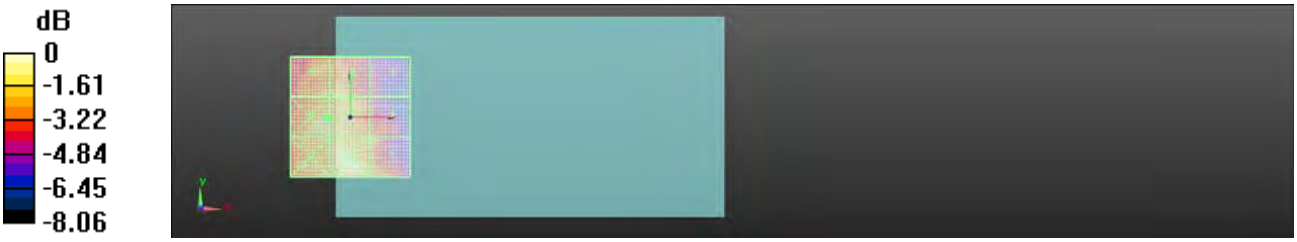
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch with AMCC
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 23.79 V/m; Power Drift = 0.04 dB
Applied MIF = 3.26 dB
RF audio interference level = 31.02 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **29.03 dBV/m**	Grid 2 **M4** **31.1 dBV/m**	Grid 3 **M4** **31.23 dBV/m**
Grid 4 **M4** **28.74 dBV/m**	Grid 5 **M4** **31.02 dBV/m**	Grid 6 **M4** **31.38 dBV/m**
Grid 7 **M4** **27.63 dBV/m**	Grid 8 **M4** **30.26 dBV/m**	Grid 9 **M4** **30.38 dBV/m**

Cursor:
Total = 31.38 dBV/m
E Category: M4
Location: -10, -0.5, 8.7 mm



0 dB = 37.09 V/m = 31.39 dBV/m

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Date: 2017/3/3

HAC-E_CDMA PCS(BC1)_CH 25

Communication System: CDMA; Frequency: 1851.25 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

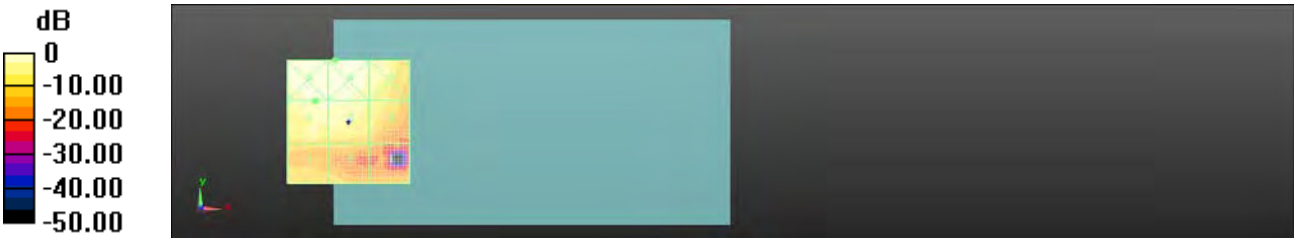
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch with AMCC
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 8.619 V/m; Power Drift = 0.15 dB
Applied MIF = 3.26 dB
RF audio interference level = 23.06 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **13.07 dBV/m**	Grid 2 **M4** **15.16 dBV/m**	Grid 3 **M4** **16.36 dBV/m**
Grid 4 **M4** **19.27 dBV/m**	Grid 5 **M4** **22.95 dBV/m**	Grid 6 **M4** **23.06 dBV/m**
Grid 7 **M4** **23.39 dBV/m**	Grid 8 **M4** **25.86 dBV/m**	Grid 9 **M4** **25.05 dBV/m**

Cursor:
Total = 25.86 dBV/m
E Category: M4
Location: -5.5, 25, 8.7 mm



0 dB = 19.63 V/m = 25.86 dBV/m

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Date: 2017/3/3

HAC-E_CDMA PCS(BC1)_CH 600
Communication System: CDMA; Frequency: 1880 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

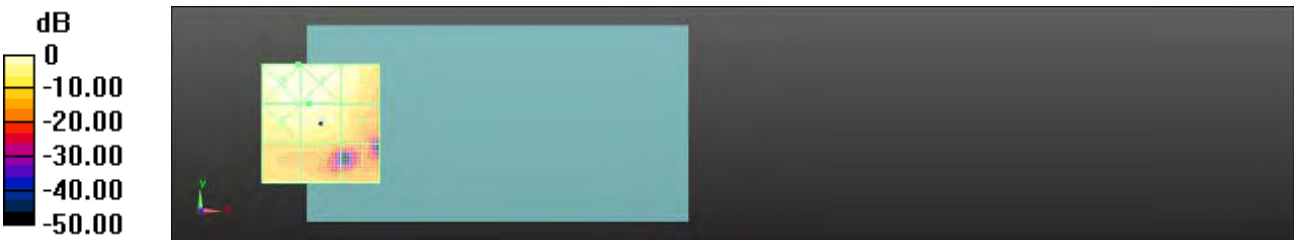
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch with AMCC
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 9.837 V/m; Power Drift = 0.16 dB
Applied MIF = 3.26 dB
RF audio interference level = 23.79 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **12.88 dBV/m**	Grid 2 **M4** **15.61 dBV/m**	Grid 3 **M4** **16.94 dBV/m**
Grid 4 **M4** **19.23 dBV/m**	Grid 5 **M4** **23.79 dBV/m**	Grid 6 **M4** **23.1 dBV/m**
Grid 7 **M4** **22.69 dBV/m**	Grid 8 **M4** **25.67 dBV/m**	Grid 9 **M4** **25.75 dBV/m**

Cursor:
Total = 25.75 dBV/m
E Category: M4
Location: -9.5, 25, 8.7 mm



0 dB = 19.39 V/m = 25.75 dBV/m

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Date: 2017/3/3

HAC-E_CDMA PCS(BC1)_CH 1175

Communication System: CDMA; Frequency: 1908.75 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

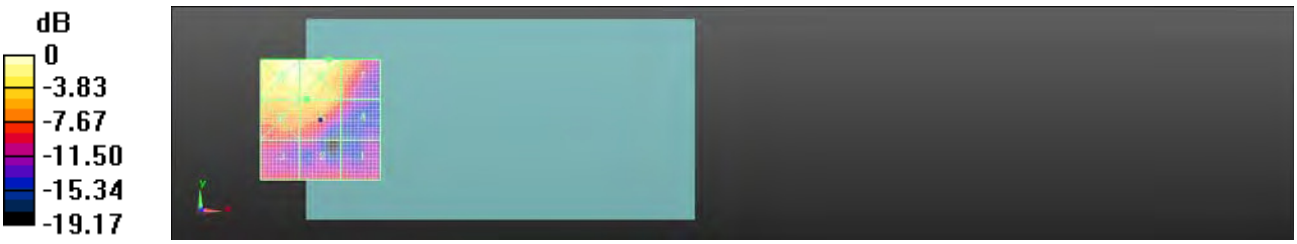
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch with AMCC
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Device E-Field measurement /E Scan: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 7.316 V/m; Power Drift = -0.05 dB
Applied MIF = 3.26 dB
RF audio interference level = 23.26 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **17.36 dBV/m**	Grid 2 **M4** **17.62 dBV/m**	Grid 3 **M4** **18.27 dBV/m**
Grid 4 **M4** **18.97 dBV/m**	Grid 5 **M4** **23.26 dBV/m**	Grid 6 **M4** **23.08 dBV/m**
Grid 7 **M4** **22.47 dBV/m**	Grid 8 **M4** **26.5 dBV/m**	Grid 9 **M4** **25.9 dBV/m**

Cursor:
Total = 26.50 dBV/m
E Category: M4
Location: 3.5, 25, 8.7 mm



0 dB = 21.13 V/m = 26.50 dBV/m

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17. System Verification

Date: 2016/5/13

Dipole CD835_SN:1052
Communication System: CW; Frequency: 835 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section
DASY5 Configuration:

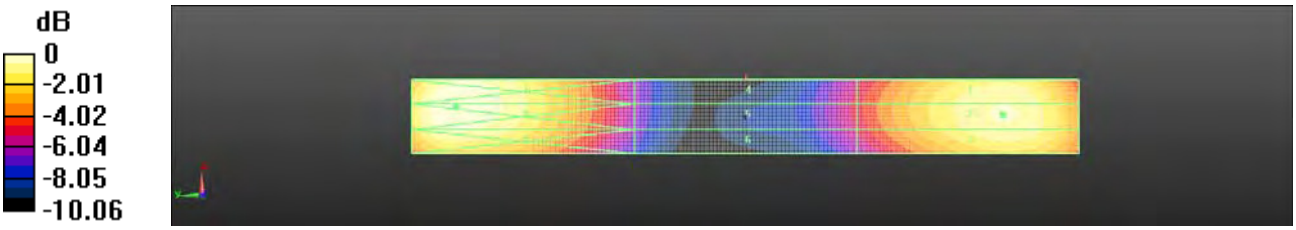
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 110.7 V/m; Power Drift = -0.01 dB
E-field emissions = 106.6 V/m
Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 **M4** **105.4 V/m**	Grid 2 **M4** **106.6 V/m**	Grid 3 **M4** **103.9 V/m**
Grid 4 **M4** **63.93 V/m**	Grid 5 **M4** **64.09 V/m**	Grid 6 **M4** **61.99 V/m**
Grid 7 **M4** **114.0 V/m**	Grid 8 **M4** **114.0 V/m**	Grid 9 **M4** **107.0 V/m**

Cursor:
Total = 114.0 V/m
E Category: M4
Location: 3, 78, 9.7 mm



0 dB = 114.0 V/m = 41.14 dBV/m

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Date: 2016/5/13

Dipole CD1880_SN:1044

Communication System: CW; Frequency: 1880 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

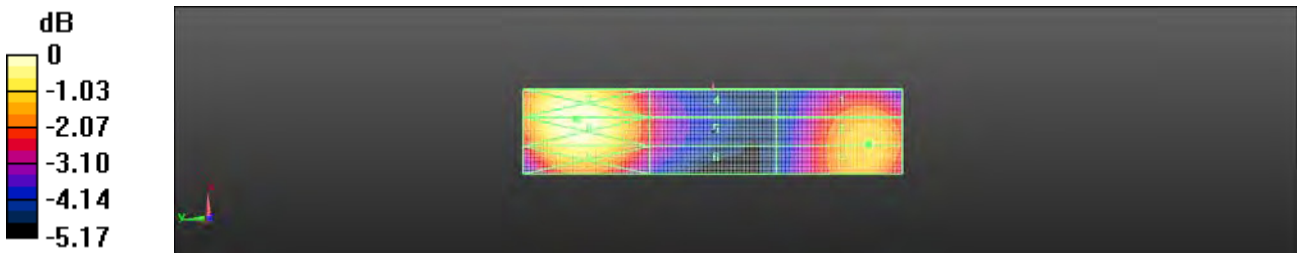
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2015/11/20;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2015/10/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 151.8 V/m; Power Drift = 0.00 dB
E-field emissions = 90.46 V/m
Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

Grid 1 **M3** **84.88 V/m**	Grid 2 **M3** **90.46 V/m**	Grid 3 **M3** **90.42 V/m**
Grid 4 **M3** **76.16 V/m**	Grid 5 **M3** **76.64 V/m**	Grid 6 **M3** **74.39 V/m**
Grid 7 **M3** **101.4 V/m**	Grid 8 **M3** **101.4 V/m**	Grid 9 **M3** **96.03 V/m**

Cursor:
Total = 101.4 V/m
E Category: M3
Location: 3, 32.5, 9.7 mm



0 dB = 101.4 V/m = 40.12 dBV/m

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Date: 2017/3/3

Dipole CD835_SN:1052

Communication System: CW; Frequency: 835 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

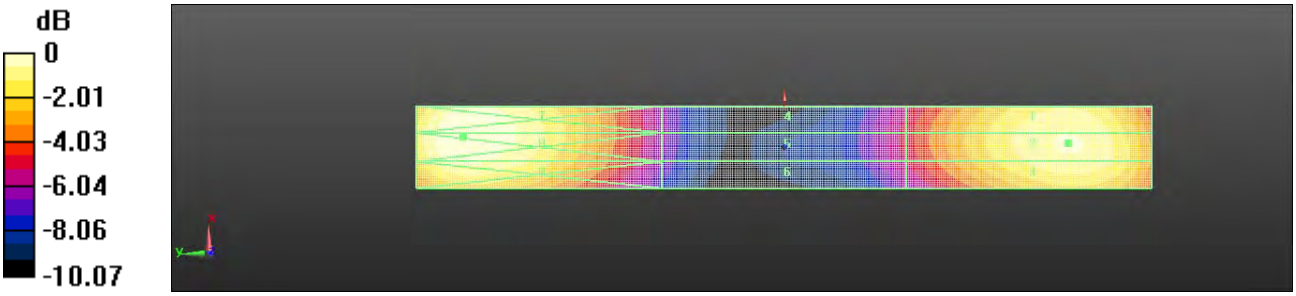
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Dipole E-Field measurement: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 110.7 V/m; Power Drift = -0.03 dB
PMR not calibrated. PMF = 1.000 is applied.
E-field emissions = 106.5 V/m
Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 **M4** **105.5 V/m**	Grid 2 **M4** **106.5 V/m**	Grid 3 **M4** **103.8 V/m**
Grid 4 **M4** **63.99 V/m**	Grid 5 **M4** **64.13 V/m**	Grid 6 **M4** **61.95 V/m**
Grid 7 **M4** **113.9 V/m**	Grid 8 **M4** **114.0 V/m**	Grid 9 **M4** **107.2 V/m**

Cursor:
Total = 114.0 V/m
E Category: M4
Location: 2.5, 78.5, 9.7 mm



0 dB = 114.0 V/m = 41.14 dBV/m

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Date: 2017/3/3

Dipole CD1880_SN:1044

Communication System: CW; Frequency: 1880 MHz
Medium parameters used: σ = 0 S/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: RF Section

DASY5 Configuration:

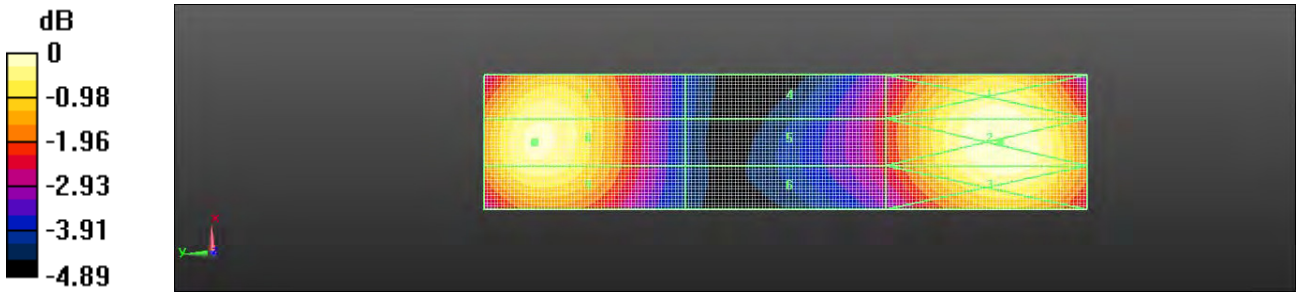
- Probe: ER3DV6 - SN2306; ConvF(1, 1, 1); Calibrated: 2016/11/23;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1374; Calibrated: 2016/8/23
- Phantom: HAC Test Arch
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7373)

Dipole E-Field measurement: Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 162.3 V/m; Power Drift = -0.01 dB
PMR not calibrated. PMF = 1.000 is applied.
E-field emissions = 90.45 V/m
Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

Grid 1 **M3** **91.70 V/m**	Grid 2 **M3** **92.98 V/m**	Grid 3 **M3** **91.35 V/m**
Grid 4 **M3** **71.20 V/m**	Grid 5 **M3** **71.69 V/m**	Grid 6 **M3** **70.44 V/m**
Grid 7 **M3** **89.30 V/m**	Grid 8 **M3** **90.45 V/m**	Grid 9 **M3** **88.78 V/m**

Cursor:
Total = 92.98 V/m
E Category: M3
Location: 0, -32, 9.7 mm



0 dB = 92.98 V/m = 39.37 dBV/m

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18. DAE & Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client SGS - TW (Auden)

Certificate No: DAE4-1374_Oct15

CALIBRATION CERTIFICATE

Object	DAE4 - SD 000 D04 BM - SN: 1374
Calibration procedure(s)	QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE)
Calibration date:	October 23, 2015

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	09-Sep-15 (No:17153)	Sep-16
Secondary Standards	**ID #**	**Check Date (in house)**	**Scheduled Check**
Auto DAE Calibration Unit	SE UWS 053 AA 1001	06-Jan-15 (in house check)	In house check: Jan-16
Calibrator Box V2.1	SE UMS 006 AA 1002	06-Jan-15 (in house check)	In house check: Jan-16

	Name	Function	Signature
Calibrated by:	Dominique Steffen	Technician	
Approved by:	Fin Bomholt	Deputy Technical Manager	

Issued: October 23, 2015

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE4-1374_Oct15 Page 1 of 5

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Calibration Laboratory of
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Accreditation No.: SCS 0108

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
  - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
  - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
  - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
  - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - *Input resistance:* Typical value for information; DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
  - *Power consumption:* Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1μV , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.597 ± 0.02% (k=2)	403.842 ± 0.02% (k=2)	404.121 ± 0.02% (k=2)
Low Range	3.98111 ± 1.50% (k=2)	3.96638 ± 1.50% (k=2)	3.98936 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	41.0 ° ± 1 °

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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (µV)	Difference (µV)	Error (%)
Channel X	+ Input	200033.09	-0.21	-0.00
Channel X	+ Input	20006.43	2.25	0.01
Channel X	- Input	-20003.08	2.09	-0.01
Channel Y	+ Input	200033.11	-0.07	-0.00
Channel Y	+ Input	20001.24	-2.89	-0.01
Channel Y	- Input	-20006.12	-0.87	0.00
Channel Z	+ Input	200032.98	-0.38	-0.00
Channel Z	+ Input	20001.71	-2.35	-0.01
Channel Z	- Input	-20007.05	-1.72	0.01

Low Range		Reading (µV)	Difference (µV)	Error (%)
Channel X	+ Input	2000.72	0.10	0.00
Channel X	+ Input	200.90	0.07	0.04
Channel X	- Input	-198.32	0.99	-0.50
Channel Y	+ Input	2000.56	-0.00	-0.00
Channel Y	+ Input	199.87	-0.82	-0.41
Channel Y	- Input	-199.92	-0.51	0.26
Channel Z	+ Input	2000.72	0.21	0.01
Channel Z	+ Input	199.48	-1.11	-0.56
Channel Z	- Input	-200.66	-1.13	0.57

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (µV)	Low Range Average Reading (µV)
Channel X	200	6.36	3.97
	- 200	-2.21	-4.56
Channel Y	200	7.13	6.98
	- 200	-8.29	-8.73
Channel Z	200	6.37	6.35
	- 200	-9.60	-9.25

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	-2.02	-1.56
Channel Y	200	4.68	-	-1.06
Channel Z	200	11.09	1.58	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15950	15957
Channel Y	16166	15762
Channel Z	16101	16123

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10MΩ

	Average (µV)	min. Offset (µV)	max. Offset (µV)	Std. Deviation (µV)
Channel X	0.61	-0.78	1.59	0.44
Channel Y	-0.47	-2.13	0.46	0.39
Channel Z	-0.68	-1.72	0.64	0.41

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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Accreditation No.: SCS 0108

Client SGS-TW (Auden)

Certificate No: DAE4-1374_Aug16

CALIBRATION CERTIFICATE

Object	DAE4 - SD 000 D04 BM - SN: 1374
Calibration procedure(s)	QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE)
Calibration date:	August 23, 2016

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of this certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	09-Sep-15 (No:17153)	Sep-16
Secondary Standards	**ID #**	**Check Date (in house)**	**Scheduled Check**
Auto DAE Calibration Unit	SE UWS 053 AA 1001	05-Jan-16 (in house check)	In house check: Jan-17
Calibrator Box V2.1	SE UMS 006 AA 1002	05-Jan-16 (in house check)	In house check: Jan-17

	Name	Function	Signature
Calibrated by:	Dominique Steffen	Technician	
Approved by:	Fin Bomholt	Deputy Technical Manager	i.V. B/

Issued: August 23, 2016

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Accreditation No.: SCS 0108

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
  - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
  - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
  - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
  - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1μV , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.637 ± 0.02% (k=2)	403.886 ± 0.02% (k=2)	404.160 ± 0.02% (k=2)
Low Range	3.98275 ± 1.50% (k=2)	3.96719 ± 1.50% (k=2)	3.99036 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	42.5 ° ± 1 °

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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (µV)	Difference (µV)	Error (%)
Channel X	+ Input	200039.11	0.18	0.00
Channel X	+ Input	20005.23	0.57	0.00
Channel X	- Input	-20004.46	1.52	-0.01
Channel Y	+ Input	200041.10	3.98	0.00
Channel Y	+ Input	20002.96	-1.76	-0.01
Channel Y	- Input	-20007.46	-1.33	0.01
Channel Z	+ Input	200039.71	2.56	0.00
Channel Z	+ Input	20002.57	-2.04	-0.01
Channel Z	- Input	-20008.39	-2.20	0.01

Low Range		Reading (µV)	Difference (µV)	Error (%)
Channel X	+ Input	2001.14	0.37	0.02
Channel X	+ Input	200.90	0.07	0.03
Channel X	- Input	-198.75	0.41	-0.20
Channel Y	+ Input	2000.82	0.06	0.00
Channel Y	+ Input	200.17	-0.51	-0.25
Channel Y	- Input	-199.47	-0.29	0.15
Channel Z	+ Input	2000.50	-0.29	-0.01
Channel Z	+ Input	199.36	-1.24	-0.62
Channel Z	- Input	-200.79	-1.45	0.73

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (µV)	Low Range Average Reading (µV)
Channel X	200	6.08	3.93
	- 200	-2.69	-4.73
Channel Y	200	7.56	7.12
	- 200	-8.69	-8.88
Channel Z	200	5.83	5.96
	- 200	-8.94	-9.16

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	-2.29	-1.91
Channel Y	200	4.65	-	-1.13
Channel Z	200	10.99	2.02	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15938	14709
Channel Y	16155	14646
Channel Z	16095	15566

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10MΩ

	Average (µV)	min. Offset (µV)	max. Offset (µV)	Std. Deviation (µV)
Channel X	1.17	0.20	1.90	0.33
Channel Y	0.61	-0.17	1.24	0.30
Channel Z	-1.30	-2.42	-0.33	0.37

6. Input Offset Current

Nominal input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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Accreditation No.: **SCS 0108**

Client **SGS-TW (Auden)**

Certificate No: **ER3-2306_Nov15**

CALIBRATION CERTIFICATE

Object	ER3DV6 - SN:2306
Calibration procedure(s)	QA CAL-02.v8, QA CAL-25.v6 Calibration procedure for E-field probes optimized for close near field evaluations in air
Calibration date:	November 20, 2015

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	01-Apr-15 (No. 217-02128)	Mar-16
Power sensor E4412A	MY41498087	01-Apr-15 (No. 217-02128)	Mar-16
Reference 3 dB Attenuator	SN: S5054 (3c)	01-Apr-15 (No. 217-02129)	Mar-16
Reference 20 dB Attenuator	SN: S5277 (20x)	01-Apr-15 (No. 217-02132)	Mar-16
Reference 30 dB Attenuator	SN: S5129 (30b)	01-Apr-15 (No. 217-02133)	Mar-16
Reference Probe ER3DV6	SN: 2328	12-Oct-15 (No. ER3-2328_Oct15)	Oct-16
DAE4	SN: 789	16-Mar-15 (No. DAE4-789_Mar16)	Mar-16
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-13)	In house check: Apr-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16

	Name	Function	Signature
Calibrated by:	Claudio Leubler	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: November 21, 2015

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Accreditation No.: **SCS 0108**

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.
b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.0, November 2013

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z*: Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart).
- *DCPx,y,z*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *PAR*: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- *Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z*: *A, B, C, D* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode
- *Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).

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Probe ER3DV6

SN:2306

Manufactured: December 17, 2002
Calibrated: November 20, 2015

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

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DASY/EASY - Parameters of Probe: ER3DV6 - SN:2306

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$)	1.08	1.12	1.23	± 10.1 %
DCP (mV)[B]	102.8	101.2	105.2	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√µV	C	D dB	VR mV	Unc[E] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	155.0	±3.0 %
		Y	0.0	0.0	1.0		166.6	
		Z	0.0	0.0	1.0		158.1	
10010-CAA	SAR Validation (Square, 100ms, 10ms)	X	0.34	50.0	4.4	10.00	36.4	±2.7 %
		Y	0.43	49.8	2.6		38.0	
		Z	0.39	49.9	4.1		37.2	
10011-CAB	UMTS-FDD (WCDMA)	X	3.07	66.2	18.2	2.91	122.1	±0.5 %
		Y	3.08	66.1	18.1		133.0	
		Z	3.29	67.7	18.9		124.0	
10021-DAB	GSM-FDD (TDMA, GMSK)	X	2.69	71.9	17.0	9.39	130.8	±1.9 %
		Y	2.34	71.2	16.9		137.4	
		Z	2.66	69.6	15.3		131.2	
10081-CAB	CDMA2000 (1xRTT, RC3)	X	3.47	64.6	17.8	3.97	113.7	±0.5 %
		Y	3.60	65.3	18.2		125.9	
		Z	3.68	66.1	18.6		117.1	
10295-AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	X	5.42	70.1	26.7	12.49	80.7	±1.4 %
		Y	5.56	71.3	27.8		87.9	
		Z	5.89	71.7	26.9		84.9	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[B] Numerical linearization parameter: uncertainty not required.
[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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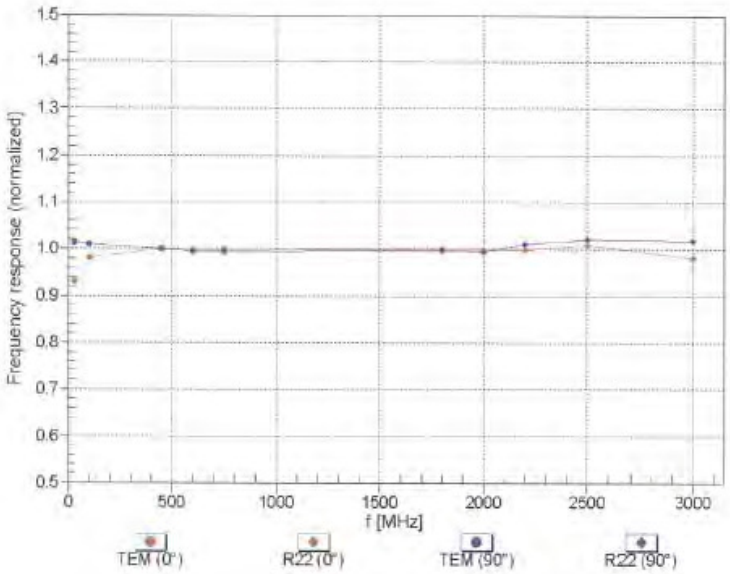
ER3DV6 – SN:2306 November 20, 2015

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

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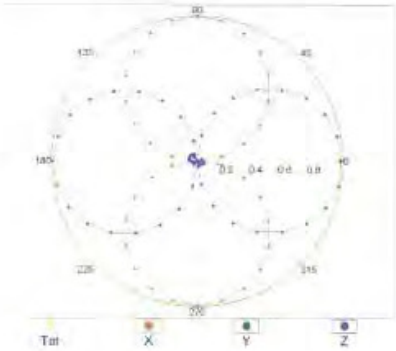
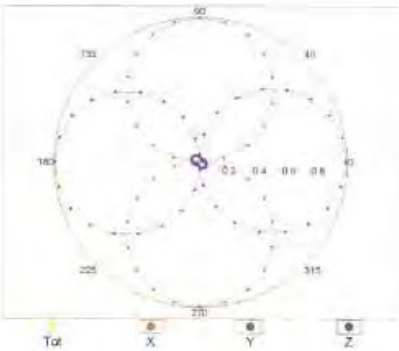
Receiving Pattern (ϕ), ϑ = 0°

f=600 MHz,TEM,0°

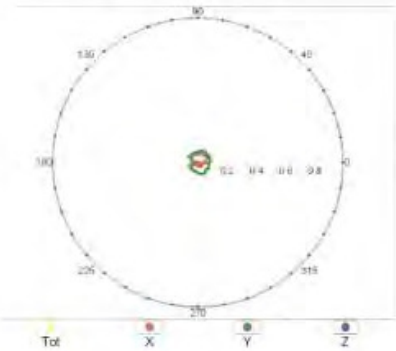


f=2500 MHz,R22,0°

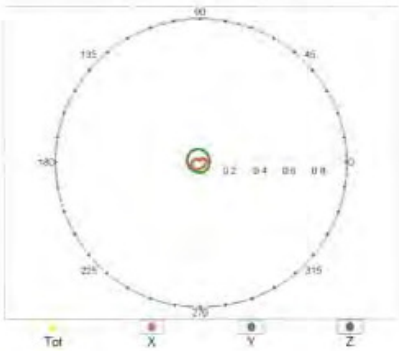


Receiving Pattern (ϕ), ϑ = 90°

f=600 MHz,TEM,90°



f=2500 MHz,R22,90°



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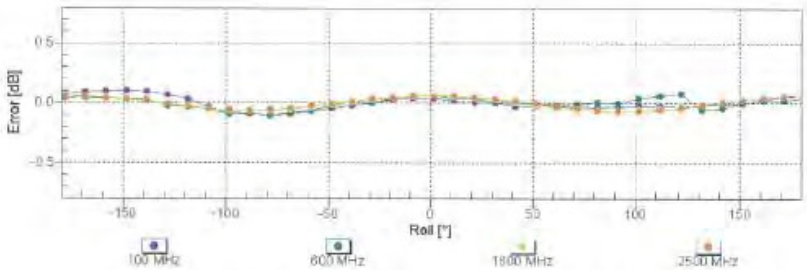
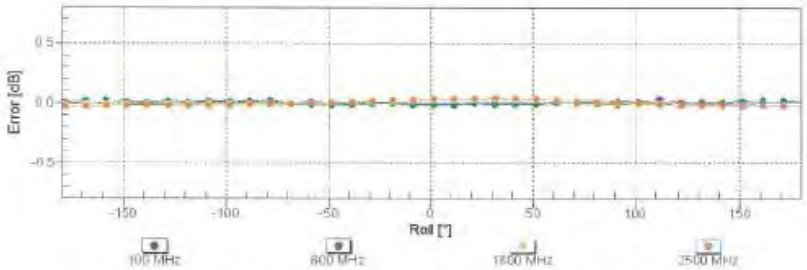
Receiving Pattern (ϕ), ϑ = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), ϑ = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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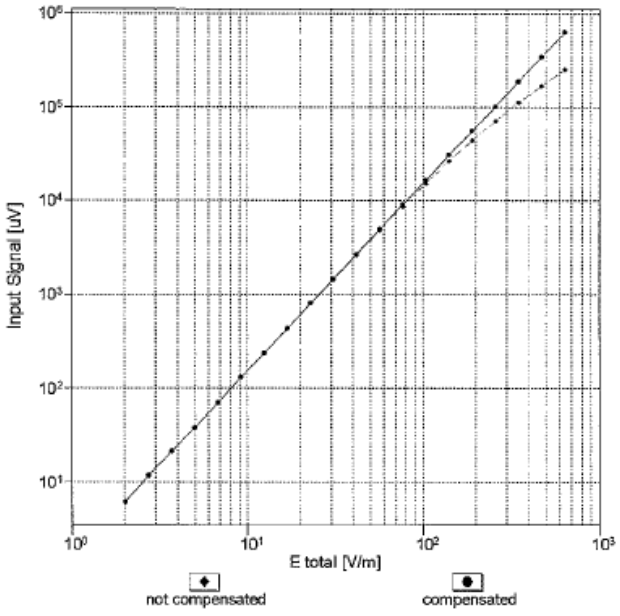
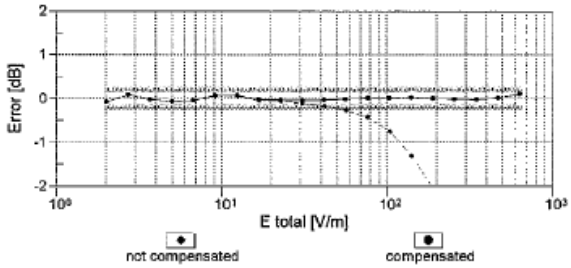
Dynamic Range f(E-field)
(TEM cell , f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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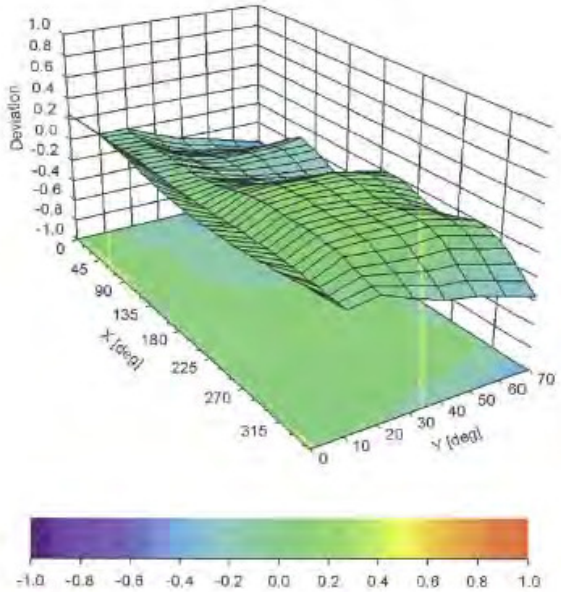
ER3DV6 – SN:2306 November 20, 2015

Deviation from Isotropy in Air

Error (ϕ, ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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DASY/EASY - Parameters of Probe: ER3DV6 - SN:2306

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	131.6
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: **SCS 0108**

Client **SGS-TW (Auden)**

Certificate No: **ER3-2306_Nov16**

CALIBRATION CERTIFICATE

Object	ER3DV6 - SN:2306
Calibration procedure(s)	QA CAL-02.v8, QA CAL-25.v6 Calibration procedure for E-field probes optimized for close near field evaluations in air
Calibration date:	November 23, 2016

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	06-Apr-16 (No. 217-02288/02289)	Apr-17
Power sensor NRP-Z91	SN: 103244	06-Apr-16 (No. 217-02288)	Apr-17
Power sensor NRP-Z91	SN: 103245	06-Apr-16 (No. 217-02289)	Apr-17
Reference 20 dB Attenuator	SN: S5277 (20x)	05-Apr-16 (No. 217-02293)	Apr-17
Reference Probe ER3DV6	SN: 2328	14-Oct-16 (No. ER3-2328_Oct16)	Oct-17
DAE4	SN: 789	11-Nov-16 (No. DAE4-789_Nov16)	Nov-17
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-16)	In house check: Jun-18
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-16)	In house check: Jun-18
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-16)	In house check: Jun-18
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-16)	In house check: Jun-18
Network Analyzer HP 8753E	SN: US37390585	18 Oct 01 (in house check Oct 16)	In house check: Oct-17

	Name	Function	Signature
Calibrated by:	Michael Weber	Laboratory Technician	M.Weber
Approved by:	Katja Pokovic	Technical Manager	

Issued: November 25, 2016

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Accreditation No.: SCS 0108

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center) i.e., ϑ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.0, November 2013

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z*: Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart).
- *DCPx,y,z*: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *PAR*: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- *Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z*: *A, B, C, D* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode
- *Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).

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Probe ER3DV6

SN:2306

Manufactured: December 17, 2002
Calibrated: November 23, 2016

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

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DASY/EASY - Parameters of Probe: ER3DV6 - SN:2306

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m)²)	1.05	1.08	1.19	± 10.1 %
DCP (mV)[B]	102.1	101.9	104.6	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√µV	C	D dB	VR mV	Unc[E] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	153.2	±3.3 %
		Y	0.0	0.0	1.0		166.4	
		Z	0.0	0.0	1.0		156.4	
10010-CAA	SAR Validation (Square, 100ms, 10ms)	X	0.33	50.6	4.6	10.00	36.4	±2.7 %
		Y	0.34	49.4	4.6		37.9	
		Z	0.42	50.7	4.4		36.9	
10021-DAC	GSM-FDD (TDMA, GMSK)	X	2.39	69.1	15.0	9.39	131.5	±2.5 %
		Y	3.16	76.0	19.5		139.0	
		Z	2.56	68.9	15.1		130.6	
10295-AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	X	5.49	70.5	26.8	12.49	80.8	±1.4 %
		Y	5.73	72.3	28.6		87.7	
		Z	6.01	72.1	27.0		84.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[A] Numerical linearization parameter: uncertainty not required.
[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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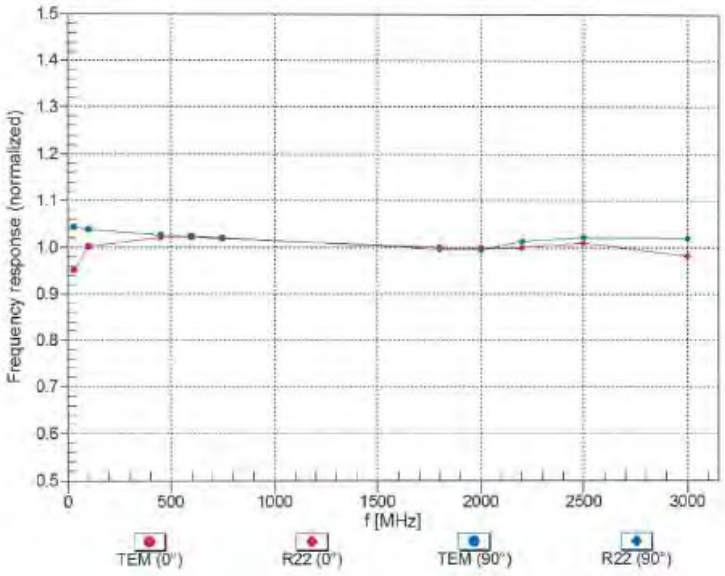
ER3DV6 – SN:2306 November 23, 2016

Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

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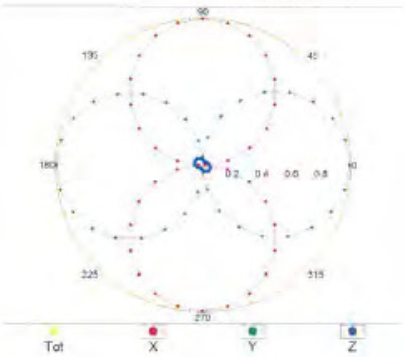
Receiving Pattern (ϕ), ϑ = 0°

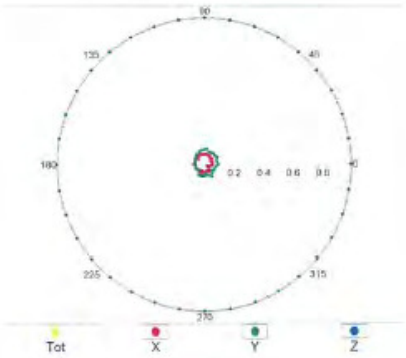
f=600 MHz,TEM,0°

f=2500 MHz,R22,0°

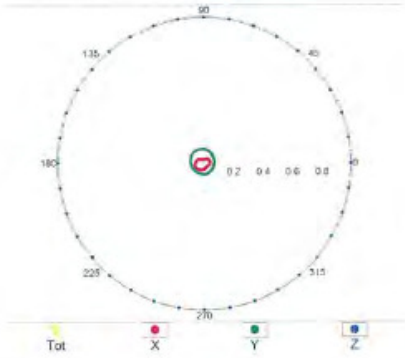


Receiving Pattern (ϕ), ϑ = 90°

f=600 MHz,TEM,90°



f=2500 MHz,R22,90°



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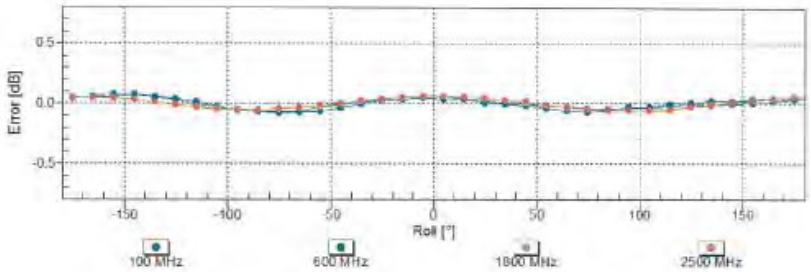
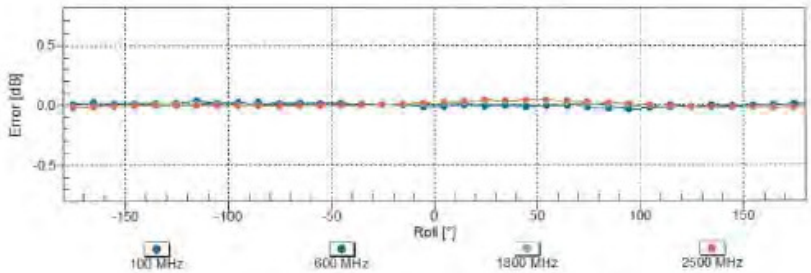
Receiving Pattern (ϕ), ϑ = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), ϑ = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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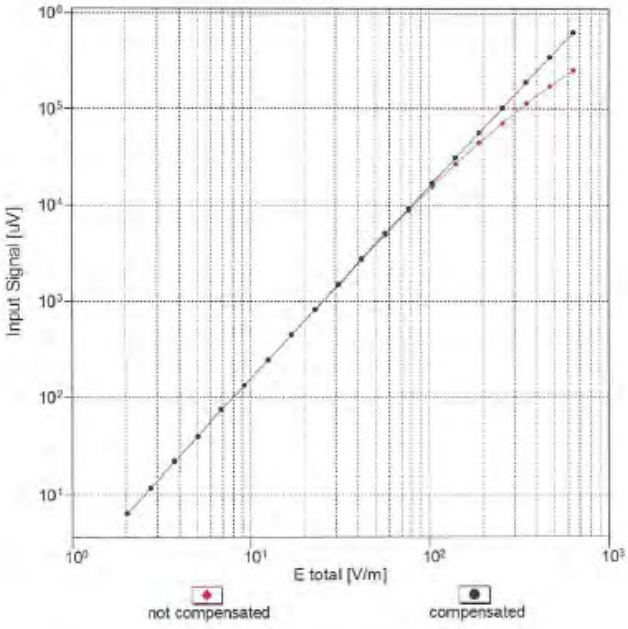
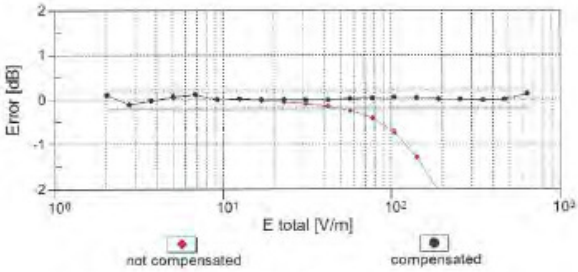
Dynamic Range f(E-field)
(TEM cell , f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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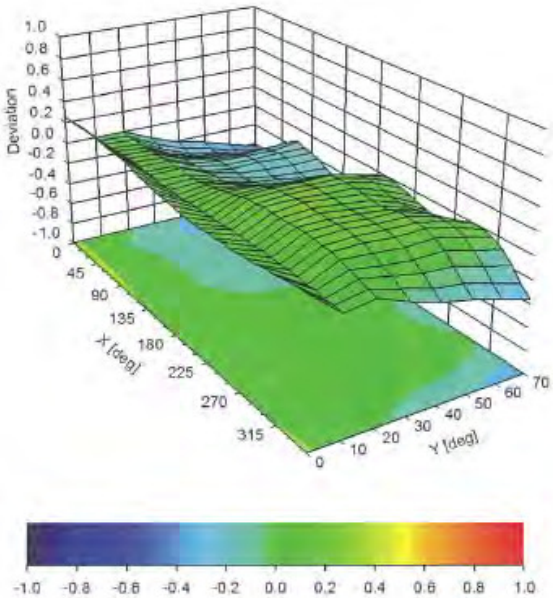
ER3DV6 – SN:2306 November 23, 2016

Deviation from Isotropy in Air

Error (ϕ, ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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DASY/EASY - Parameters of Probe: ER3DV6 - SN:2306

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	134.7
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

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19. Uncertainty Budget

HAC Uncertainty Budget According to ANSI C63.19 [1], [2]							
Error Description	Uncert. value	Prob. Dist.	Div.	(c_i) E	(c_i) H	Std. Unc. E	Std. Unc. H
Measurement System							
Probe Calibration	±5.1 %	N	1	1	1	±5.1 %	±5.1 %
Axial Isotropy	±4.7 %	R	$\sqrt{3}$	1	1	±2.7 %	±2.7 %
Sensor Displacement	±16.5 %	R	$\sqrt{3}$	1	0.145	±9.5 %	±1.4 %
Boundary Effects	±2.4 %	R	$\sqrt{3}$	1	1	±1.4 %	±1.4 %
Phantom Boundary Effect	±7.2 %	R	$\sqrt{3}$	1	0	±4.1 %	±0.0 %
Linearity	±4.7 %	R	$\sqrt{3}$	1	1	±2.7 %	±2.7 %
Scaling with PMR calibration	±10.0 %	R	$\sqrt{3}$	1	1	±5.8 %	±5.8 %
System Detection Limit	±1.0 %	R	$\sqrt{3}$	1	1	±0.6 %	±0.6 %
Readout Electronics	±0.3 %	N	1	1	1	±0.3 %	±0.3 %
Response Time	±0.8 %	R	$\sqrt{3}$	1	1	±0.5 %	±0.5 %
Integration Time	±2.6 %	R	$\sqrt{3}$	1	1	±1.5 %	±1.5 %
RF Ambient Conditions	±3.0 %	R	$\sqrt{3}$	1	1	±1.7 %	±1.7 %
RF Reflections	±12.0 %	R	$\sqrt{3}$	1	1	±6.9 %	±6.9 %
Probe Positioner	±1.2 %	R	$\sqrt{3}$	1	0.67	±0.7 %	±0.5 %
Probe Positioning	±4.7 %	R	$\sqrt{3}$	1	0.67	±2.7 %	±1.8 %
Extrap. and Interpolation	±1.0 %	R	$\sqrt{3}$	1	1	±0.6 %	±0.6 %
Test Sample Related							
Device Positioning Vertical	±4.7 %	R	$\sqrt{3}$	1	0.67	±2.7 %	±1.8 %
Device Positioning Lateral	±1.0 %	R	$\sqrt{3}$	1	1	±0.6 %	±0.6 %
Device Holder and Phantom	±2.4 %	R	$\sqrt{3}$	1	1	±1.4 %	±1.4 %
Power Drift	±5.0 %	R	$\sqrt{3}$	1	1	±2.9 %	±2.9 %
Phantom and Setup Related							
Phantom Thickness	±2.4 %	R	$\sqrt{3}$	1	0.67	±1.4 %	±0.9 %
Combined Std. Uncertainty						±16.3 %	±12.3 %
Expanded Std. Uncertainty on Power						**±32.6 %**	**±24.6 %**
Expanded Std. Uncertainty on Field						**±16.3 %**	**±12.3 %**

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20. System Validation from Original Equipment Supplier

Calibration Laboratory of
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Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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C Service suisse d'étalonnage
S Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client SGS-TW (Auden)

Certificate No: CD835V3-1052_Mar16

CALIBRATION CERTIFICATE

Object	CD835V3 - SN: 1052
Calibration procedure(s)	QA CAL-20.v6 Calibration procedure for dipoles in air
Calibration date:	March 17, 2016

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	07-Oct-15 (No. 217-02222)	Oct-16
Power sensor HP 8481A	US37292783	07-Oct-15 (No. 217-02222)	Oct-16
Power sensor HP 8481A	MY41092317	07-Oct-15 (No. 217-02223)	Oct-16
Reference 10 dB Attenuator	SN: 5047.2 / 06327	01-Apr-15 (No. 217-02130)	Mar-16
Probe ER3DV6	SN: 2336	31-Dec-15 (No. ER3-2336_Dec15)	Dec-16
Probe H3DV6	SN: 6065	31-Dec-15 (No. H3-6065_Dec15)	Dec-16
DAE4	SN: 781	04-Sep-15 (No. DAE4-781_Sep15)	Sep-16

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	In house check: Sep-16
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Sep-14)	In house check: Sep-16
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Sep-14)	In house check: Sep-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16
RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-15)	In house check: Oct-16

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: March 21, 2016

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD835V3-1052_Mar16 Page 1 of 5

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Accreditation No.: SCS 0108

References

[1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections.
  It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	110.2 V/m = 40.85 dBV/m
Maximum measured above low end	100 mW input power	106.8 V/m = 40.57 dBV/m
Averaged maximum above arm	100 mW input power	**108.5 V/m ± 12.8 % (k=2)**

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	**Return Loss**	**Impedance**
800 MHz	15.9 dB	43.2 Ω - 13.5 jΩ
835 MHz	26.6 dB	49.6 Ω + 4.6 jΩ
900 MHz	16.4 dB	57.2 Ω - 14.7 jΩ
950 MHz	20.4 dB	45.6 Ω + 8.1 jΩ
960 MHz	15.6 dB	52.2 Ω + 17.0 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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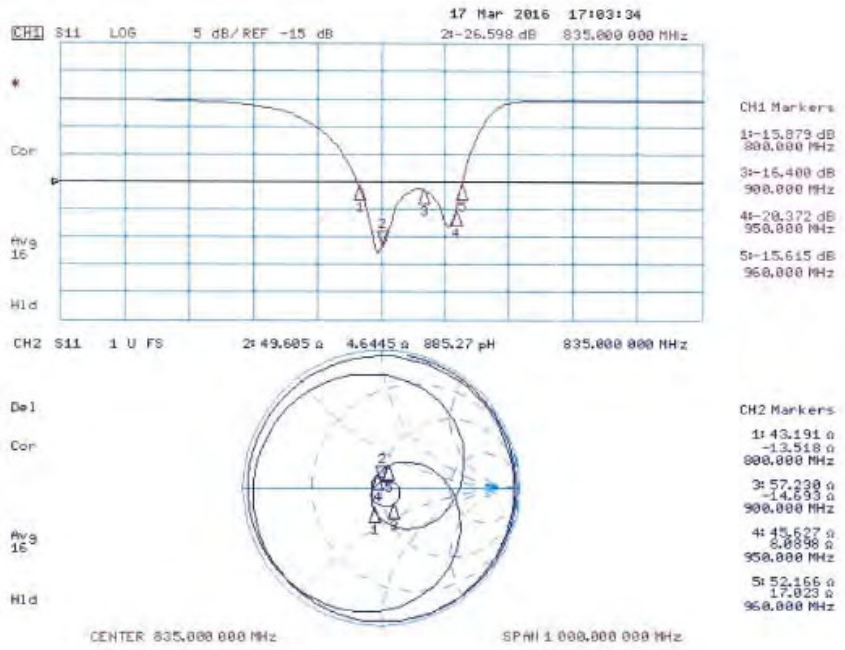
Impedance Measurement Plot



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DASY5 E-field Result

Date: 17.03.2016

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1052

Communication System: UID 0 - CW ; Frequency: 835 MHz
Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm /Hearing Aid Compatibility Test (41x361x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 113.4 V/m; Power Drift = -0.04 dB
Applied MIF = 0.00 dB
RF audio interference level = 40.85 dBV/m
Emission category: M3

MIF scaled E-field

Grid 1 **M3** **40.5 dBV/m**	Grid 2 **M3** **40.57 dBV/m**	Grid 3 **M3** **40.35 dBV/m**
Grid 4 **M4** **35.73 dBV/m**	Grid 5 **M4** **35.8 dBV/m**	Grid 6 **M4** **35.6 dBV/m**
Grid 7 **M3** **40.58 dBV/m**	Grid 8 **M3** **40.85 dBV/m**	Grid 9 **M3** **40.78 dBV/m**

0 dB = 110.2 V/m = 40.84 dBV/m

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Accreditation No.: SCS 0108

Client **SGS-TW (Auden)**

Certificate No: CD1880V3-1044_Mar16

CALIBRATION CERTIFICATE

Object	CD1880V3 - SN: 1044
Calibration procedure(s)	QA CAL-20.v6 Calibration procedure for dipoles in air
Calibration date:	March 17, 2016

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	07-Oct-15 (No. 217-02222)	Oct-16
Power sensor HP 8481A	US37292783	07-Oct-15 (No. 217-02222)	Oct-16
Power sensor HP 8481A	MY41092317	07-Oct-15 (No. 217-02223)	Oct-16
Reference 10 dB Attenuator	SN: 5047.2 / 06327	01-Apr-15 (No. 217-02130)	Mar-16
Probe ER3DV6	SN: 2336	31-Dec-15 (No. ER3-2336_Dec15)	Dec-16
Probe H3DV6	SN: 6065	31-Dec-15 (No. H3-6065_Dec15)	Dec-16
DAE4	SN: 781	04-Sep-15 (No. DAE4-781_Sep15)	Sep-16

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	In house check: Sep-16
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Sep-14)	In house check: Sep-16
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Sep-14)	In house check: Sep-16
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16
RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-15)	In house check: Oct-16

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: March 21, 2016

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Accreditation No.: **SCS 0108**

References

[1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections.
  It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	89.3 V/m = 39.01 dBV/m
Maximum measured above low end	100 mW input power	86.3 V/m = 38.72 dBV/m
Averaged maximum above arm	100 mW input power	**87.8 V/m ± 12.8 % (k=2)**

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	**Return Loss**	**Impedance**
1730 MHz	23.7 dB	49.0 Ω + 6.4 jΩ
1880 MHz	20.2 dB	51.0 Ω + 9.8 jΩ
1900 MHz	20.3 dB	54.2 Ω + 9.1 jΩ
1950 MHz	28.1 dB	54.1 Ω + 0.5 jΩ
2000 MHz	21.4 dB	42.3 Ω + 1.6 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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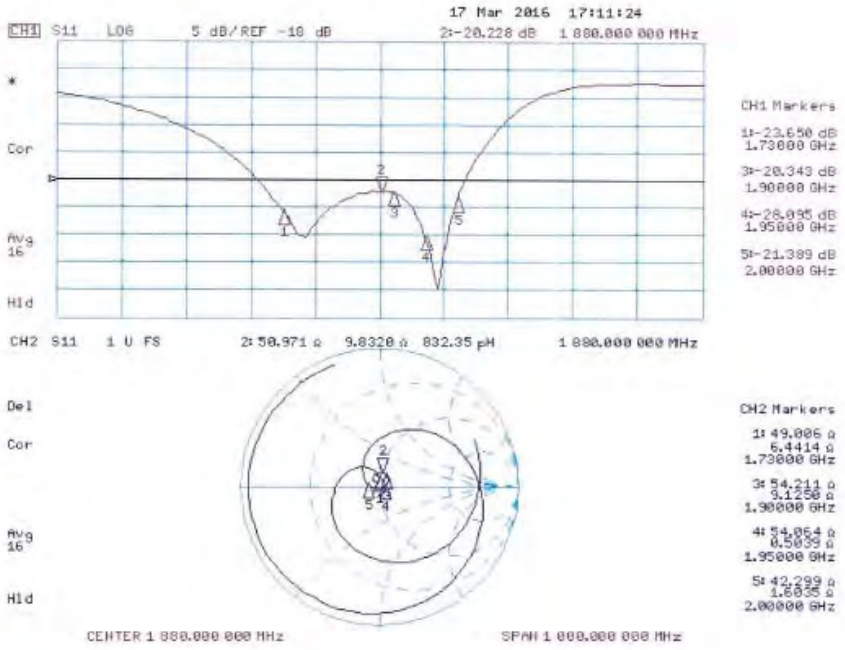
Impedance Measurement Plot



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DASY5 E-field Result

Date: 17.03.2016

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1044

Communication System: UID 0 - CW ; Frequency: 1880 MHz
Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

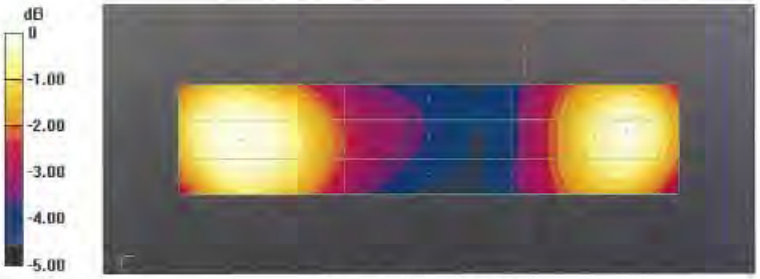
DASY52 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 147.6 V/m; Power Drift = 0.00 dB
Applied MIF = 0.00 dB
RF audio interference level = 39.01 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 M2 38.89 dBV/m	Grid 2 M2 39.01 dBV/m	Grid 3 M2 38.88 dBV/m
Grid 4 M2 36.59 dBV/m	Grid 5 M2 36.66 dBV/m	Grid 6 M2 36.53 dBV/m
Grid 7 M2 38.52 dBV/m	Grid 8 M2 38.72 dBV/m	Grid 9 M2 38.65 dBV/m



0 dB = 89.26 V/m = 39.01 dBV/m

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End of 1st part of report

Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 90 days only.
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